## Application/Control No. O9/885,213 Applicant(s)/Patent Under Reexamination KLEIER ET AL. Examiner Md S Elahee Applicant(s)/Patent Under Reexamination KLEIER ET AL. Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-6,577,721	06-2003	Vainio et al.	379/202.01
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	С	US-			
	D	US-			
	E	US-			
	F	US-			
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	1	US-			
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	К	US-			
	L	US-			
	М	US-			

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## **NON-PATENT DOCUMENTS**

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